## Docket No. 2003P53927US/I331.118.101 RANDOM ACCESS MEMORY USING PRECHARGE TIMERS IN TEST MODE Joonho Kim 1/4

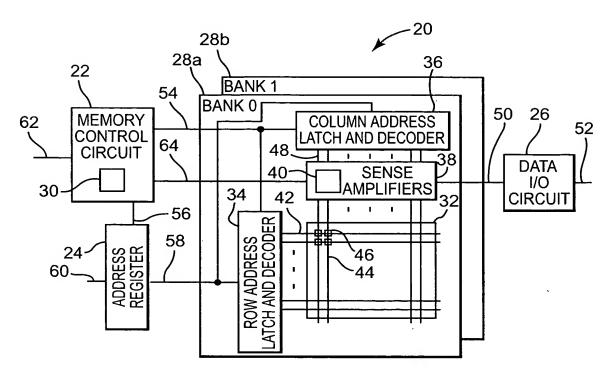


Fig. 1

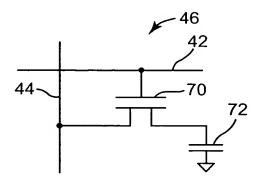
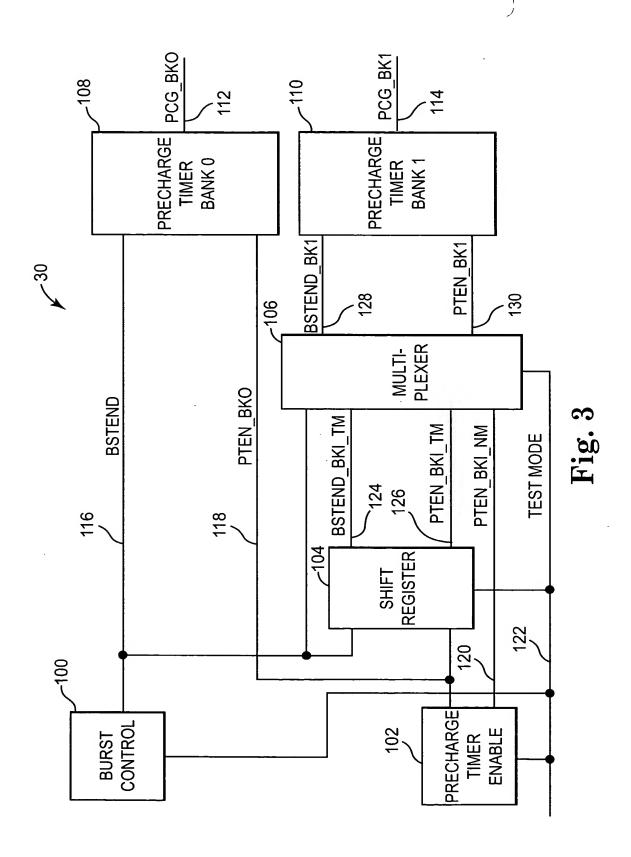


Fig. 2

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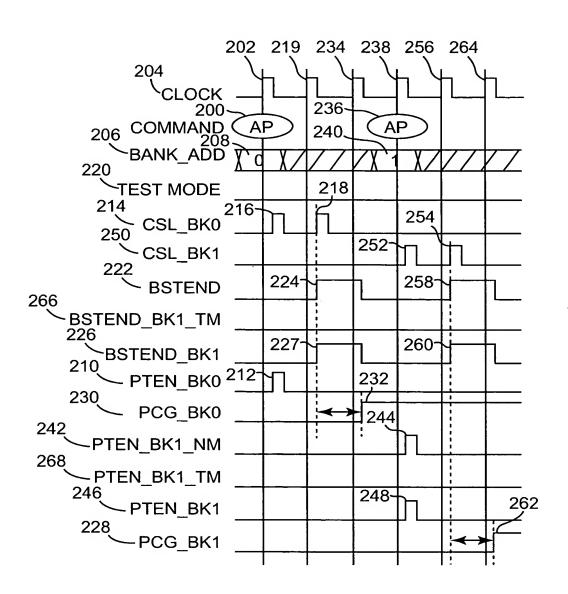


Fig. 4

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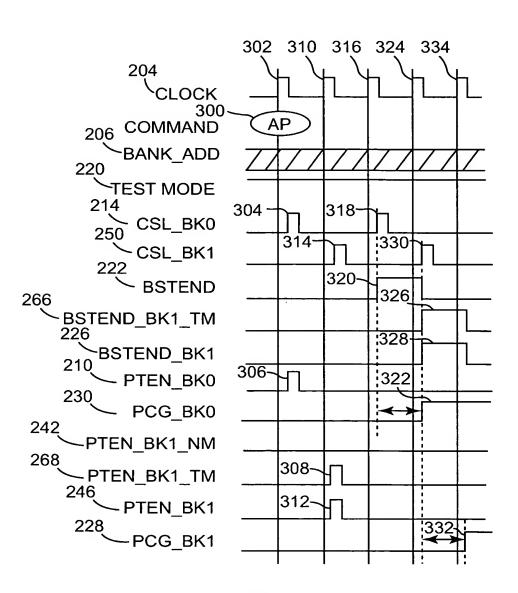


Fig. 5